## Final datasheet
## EasyDUAL module with CoolSiC™ Trench MOSFET and PressFIT / NTC

### Features


Typical appearance

- Electrical features
  - $V_{DSS}$ = 1200 V
  - $I_{DN}$ = 150 A / $I_{DRM}$ = 300 A
  - Low switching losses
  - Low inductive design
  - High current density
  - Suitable Infineon gate drivers can be found under https://www.infineon.com/gdfinder
- Mechanical features
  - Rugged mounting due to integrated mounting clamps
  - PressFIT contact technology
  - Integrated NTC temperature sensor

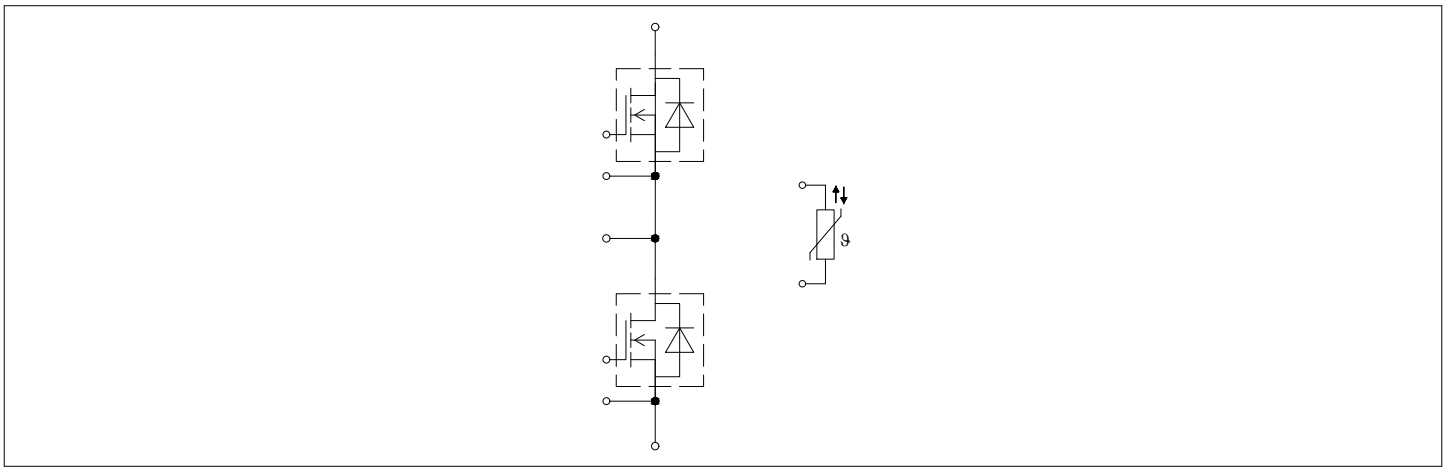
### Potential applications

- UPS systems
- High-frequency switching application
- DC/DC converter
- Solar applications

### Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

### Description



# Table of contents

# 1 Package

**Table 1 Insulation coordination**

| Parameter | Symbol | Note or test condition | Values | Unit |
|---|---|---|---|---|
| Isolation test voltage | $V_{ISOL}$ | RMS, f = 50 Hz, *t* = 1 min | 3.0 | kV |
| Isolation test voltage NTC | $V_{ISOL(NTC)}$ | RMS, f = 50 Hz, *t* = 1 min | 3.0 | kV |
| Internal isolation | | basic insulation (class 1, IEC 61140) | $Al_2O_3$ | |
| Comparative tracking index | *CTI* | | > 200 | |
| Relative thermal index (electrical) | *RTI* | housing | 140 | °C |

**Table 2 Characteristic values**

| Parameter | Symbol | Note or test condition | Values | | | Unit |
|---|---|---|---|---|---|---|
| | | | Min. | Typ. | Max. | |
| Stray inductance module | $L_{sCE}$ | | | 8 | | nH |
| Module lead resistance, terminals - chip | $R_{CC'+EE'}$ | $T_H$ = 25 °C, per switch | | 1.4 | | mΩ |
| Storage temperature | $T_{stg}$ | | -40 | | 125 | °C |
| Mounting force per clamp | *F* | | 40 | | 80 | N |
| Weight | *G* | | | 39 | | g |

***Note**: The current under continuous operation is limited to 25 A rms per connector pin.*

# 2 MOSFET

**Table 3 Maximum rated values**

| Parameter | Symbol | Note or test condition | | Values | Unit |
|---|---|---|---|---|---|
| Drain-source voltage | $V_{DSS}$ | | $T_{vj}$ = 25 °C | 1200 | V |
| Implemented drain current | $I_{DN}$ | | | 150 | A |
| Continuous DC drain current | $I_{DDC}$ | $T_{vj}$ = 175 °C, $V_{GS}$ = 18 V | $T_H$ = 65 °C | 145 | A |
| Repetitive peak drain current | $I_{DRM}$ | verified by design, $t_p$ limited by $T_{vjmax}$ | | 300 | A |
| Gate-source voltage, max. transient voltage | $V_{GS}$ | *D* < 0.01 | | -10/23 | V |
| Gate-source voltage, max. static voltage | $V_{GS}$ | | | -7/20 | V |

**Table 4 Recommended values**

| Parameter | Symbol | Note or test condition | Values | Unit |
|---|---|---|---|---|
| On-state gate voltage | $V_{GS(on)}$ | | 15...18 | V |
| Off-state gate voltage | $V_{GS(off)}$ | | -5...0 | V |

**Table 5 Characteristic values**

| Parameter | Symbol | Note or test condition | | Values | | | Unit |
|---|---|---|---|---|---|---|---|
| | | | | Min. | Typ. | Max. | |
| Drain-source on-resistance | $R_{DS(on)}$ | $I_D$ = 150 A | $V_{GS}$ = 18 V, $T_{vj}$ = 25 °C | | 5.4 | 8 | mΩ |
| | | | $V_{GS}$ = 18 V, $T_{vj}$ = 125 °C | | 8.7 | | |
| | | | $V_{GS}$ = 18 V, $T_{vj}$ = 175 °C | | 11.6 | | |
| | | | $V_{GS}$ = 15 V, $T_{vj}$ = 25 °C | | 6.5 | | |
| Gate threshold voltage | $V_{GS(th)}$ | $I_D$ = 60 mA, $V_{DS}$ = $V_{GS}$, $T_{vj}$ = 25 °C, (tested after 1ms pulse at $V_{GS}$ = +20 V) | | 3.45 | 4.3 | 5.15 | V |
| Total gate charge | $Q_G$ | $V_{DD}$ = 800 V, $V_{GS}$ = -3/18 V, $T_{vj}$ = 25 °C | | | 0.446 | | µC |
| Internal gate resistor | $R_{Gint}$ | $T_{vj}$ = 25 °C | | | 1.4 | | Ω |
| Input capacitance | $C_{ISS}$ | $f$ = 100 kHz, $V_{DS}$ = 800 V, $V_{GS}$ = 0 V | $T_{vj}$ = 25 °C | | 13.2 | | nF |
| Output capacitance | $C_{OSS}$ | $f$ = 100 kHz, $V_{DS}$ = 800 V, $V_{GS}$ = 0 V | $T_{vj}$ = 25 °C | | 0.63 | | nF |
| Reverse transfer capacitance | $C_{rss}$ | $f$ = 100 kHz, $V_{DS}$ = 800 V, $V_{GS}$ = 0 V | $T_{vj}$ = 25 °C | | 0.042 | | nF |
| $C_{OSS}$ stored energy | $E_{OSS}$ | $V_{DS}$ = 800 V, $V_{GS}$ = -3/18 V, $T_{vj}$ = 25 °C | | | 258 | | µJ |
| Drain-source leakage current | $I_{DSS}$ | $V_{DS}$ = 1200 V, $V_{GS}$ = -3 V | $T_{vj}$ = 25 °C | | 0.09 | 530 | µA |
| Gate-source leakage current | $I_{GSS}$ | $V_{DS}$ = 0 V, $T_{vj}$ = 25 °C | $V_{GS}$ = 20 V | | | 400 | nA |
| Turn-on delay time (inductive load) | $t_{d\,on}$ | $I_D$ = 150 A, $R_{Gon}$ = 2.7 Ω, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V, $t_{dead}$ = 1000 ns, 0.1 $V_{GS}$ to 0.1 $I_D$ | $T_{vj}$ = 25 °C | | 31 | | ns |
| | | | $T_{vj}$ = 125 °C | | 31 | | |
| | | | $T_{vj}$ = 175 °C | | 32 | | |
| Rise time (inductive load) | $t_r$ | $I_D$ = 150 A, $R_{Gon}$ = 2.7 Ω, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V, $t_{dead}$ = 1000 ns, 0.1 $I_D$ to 0.9 $I_D$ | $T_{vj}$ = 25 °C | | 13 | | ns |
| | | | $T_{vj}$ = 125 °C | | 13 | | |
| | | | $T_{vj}$ = 175 °C | | 14 | | |

**(table continues...)**

**Table 5 (continued) Characteristic values**

| Parameter | Symbol | Note or test condition | | Values | | | Unit |
|---|---|---|---|---|---|---|---|
| | | | | Min. | Typ. | Max. | |
| Turn-off delay time (inductive load) | $t_{d\,off}$ | $I_D$ = 150 A, $R_{Goff}$ = 0.51 Ω, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V, 0.9 $V_{GS}$ to 0.9 $I_D$ | $T_{vj}$ = 25 °C | | 35 | | ns |
| | | | $T_{vj}$ = 125 °C | | 38 | | |
| | | | $T_{vj}$ = 175 °C | | 41 | | |
| Fall time (inductive load) | $t_f$ | $I_D$ = 150 A, $R_{Goff}$ = 0.51 Ω, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V, 0.9 $I_D$ to 0.1 $I_D$ | $T_{vj}$ = 25 °C | | 11 | | ns |
| | | | $T_{vj}$ = 125 °C | | 12 | | |
| | | | $T_{vj}$ = 175 °C | | 16 | | |
| Turn-on energy loss per pulse | $E_{on}$ | $I_D$ = 150 A, $V_{DD}$ = 600 V, $L_\sigma$ = 8 nH, $V_{GS}$ = -3/18 V, $R_{Gon}$ = 2.7 Ω, di/dt = 13.5 kA/µs ($T_{vj}$ = 175 °C), $t_{dead}$ = 1000 ns | $T_{vj}$ = 25 °C | | 2.12 | | mJ |
| | | | $T_{vj}$ = 125 °C | | 2.35 | | |
| | | | $T_{vj}$ = 175 °C | | 2.67 | | |
| Turn-on energy loss per pulse, optimized | $E_{on,o}$ | $I_D$ = 150 A, $V_{DD}$ = 600 V, $L_\sigma$ = 8 nH, $V_{GS}$ = -3/18 V, $R_{Gon,o}$ = 1.5 Ω, di/dt = 18.1 kA/µs ($T_{vj}$ = 175 °C), $t_{dead}$ = 100 ns | $T_{vj}$ = 25 °C | | 1.28 | | mJ |
| | | | $T_{vj}$ = 125 °C | | 1.3 | | |
| | | | $T_{vj}$ = 175 °C | | 1.35 | | |
| Turn-off energy loss per pulse | $E_{off}$ | $I_D$ = 150 A, $V_{DD}$ = 600 V, $L_\sigma$ = 8 nH, $V_{GS}$ = -3/18 V, $R_{Goff}$ = 0.51 Ω, dv/dt = 42.5 kV/µs ($T_{vj}$ = 175 °C) | $T_{vj}$ = 25 °C | | 0.41 | | mJ |
| | | | $T_{vj}$ = 125 °C | | 0.434 | | |
| | | | $T_{vj}$ = 175 °C | | 0.445 | | |
| SC data | $I_{SC}$ | $V_{GS}$ = -5/15 V, $V_{DD}$ = 800 V, $V_{DSmax}$ = $V_{DSS}$-$L_{sDS}$*di/dt, $R_G$ = 10 Ω | $t_P$ = 2 µs, $T_{vj}$ = 25 °C | | 1260 | | A |
| | | | $t_P$ = 2 µs, $T_{vj}$ = 150 °C | | 1230 | | |
| Thermal resistance, junction to heat sink | $R_{thJH}$ | per MOSFET, $\lambda_{grease}$ = 1 W/(m·K) | | | 0.346 | | K/W |
| Temperature under switching conditions | $T_{vj\,op}$ | | | -40 | | 175 | °C |

***Note**:* *The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.*

*Tvj,op > 150°C is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.*

# 3 Body diode (MOSFET)

**Table 6 Maximum rated values**

| Parameter | Symbol | Note or test condition | | Values | Unit |
|---|---|---|---|---|---|
| DC body diode forward current | $I_{SD}$ | $T_{vj}$ = 175 °C, $V_{GS}$ = -3 V | $T_H$ = 65 °C | 75 | A |

**Table 7 Characteristic values**

| Parameter | Symbol | Note or test condition | | Values | | | Unit |
|---|---|---|---|---|---|---|---|
| | | | | Min. | Typ. | Max. | |
| Forward voltage | $V_{SD}$ | $I_{SD}$ = 150 A, $V_{GS}$ = -3 V | $T_{vj}$ = 25 °C | | 4.2 | 5.35 | V |
| | | | $T_{vj}$ = 125 °C | | 3.9 | | |
| | | | $T_{vj}$ = 175 °C | | 3.8 | | |
| Peak reverse recovery current | $I_{rrm}$ | $I_{SD}$ = 150 A, $di_s/dt$ = 13.5 kA/µs, $V_{DD}$ = 600 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns | $T_{vj}$ = 25 °C | | 106 | | A |
| | | | $T_{vj}$ = 125 °C | | 155 | | |
| | | | $T_{vj}$ = 175 °C | | 175 | | |
| Recovered charge | $Q_{rr}$ | $I_{SD}$ = 150 A, $di_s/dt$ = 13.5 kA/µs, $V_{DD}$ = 600 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns | $T_{vj}$ = 25 °C | | 1.36 | | µC |
| | | | $T_{vj}$ = 125 °C | | 2.47 | | |
| | | | $T_{vj}$ = 175 °C | | 3.2 | | |
| Reverse recovery energy | $E_{rec}$ | $I_{SD}$ = 150 A, $di_s/dt$ = 13.5 kA/µs ($T_{vj}$ = 175 °C), $V_{DD}$ = 600 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns | $T_{vj}$ = 25 °C | | 0.521 | | mJ |
| | | | $T_{vj}$ = 125 °C | | 0.863 | | |
| | | | $T_{vj}$ = 175 °C | | 1.16 | | |
| Reverse recovery energy, optimized | $E_{rec,o}$ | $I_{SD}$ = 150 A, $di_s/dt$ = 18.1 kA/µs ($T_{vj}$ = 175 °C), $V_{DD}$ = 600 V, $V_{GS}$ = -3 V, $t_{dead}$ = 100 ns | $T_{vj}$ = 25 °C | | 0.764 | | mJ |
| | | | $T_{vj}$ = 125 °C | | 0.816 | | |
| | | | $T_{vj}$ = 175 °C | | 0.963 | | |

# 4 NTC-Thermistor

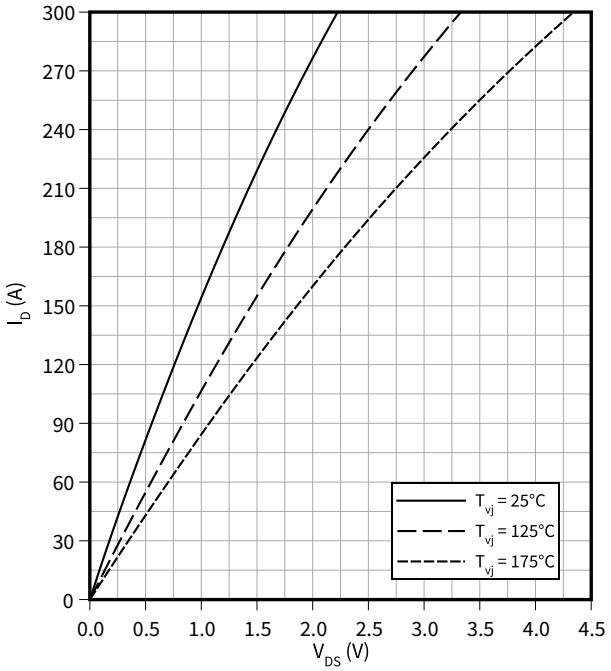
**Table 8 Characteristic values**

| Parameter | Symbol | Note or test condition | Values | | | Unit |
|---|---|---|---|---|---|---|
| | | | Min. | Typ. | Max. | |
| Rated resistance | $R_{25}$ | $T_{NTC}$ = 25 °C | | 5 | | kΩ |
| Deviation of $R_{100}$ | $\Delta R/R$ | $T_{NTC}$ = 100 °C, $R_{100}$ = 493 Ω | -5 | | 5 | % |
| Power dissipation | $P_{25}$ | $T_{NTC}$ = 25 °C | | | 20 | mW |
| B-value | $B_{25/50}$ | $R_2 = R_{25} \exp[B_{25/50}(1/T_2\text{-}1/(298{,}15\ K))]$ | | 3375 | | K |
| B-value | $B_{25/80}$ | $R_2 = R_{25} \exp[B_{25/80}(1/T_2\text{-}1/(298{,}15\ K))]$ | | 3411 | | K |
| B-value | $B_{25/100}$ | $R_2 = R_{25} \exp[B_{25/100}(1/T_2\text{-}1/(298{,}15\ K))]$ | | 3433 | | K |

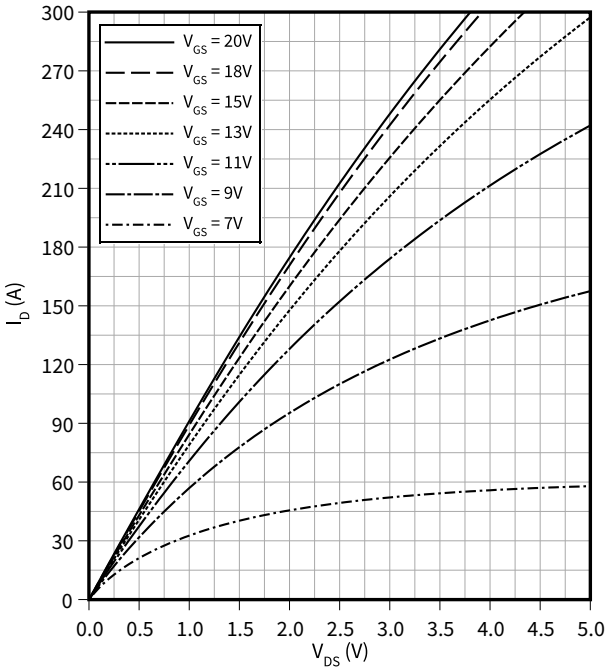
***Note**: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4.*

# 5 Characteristics diagrams

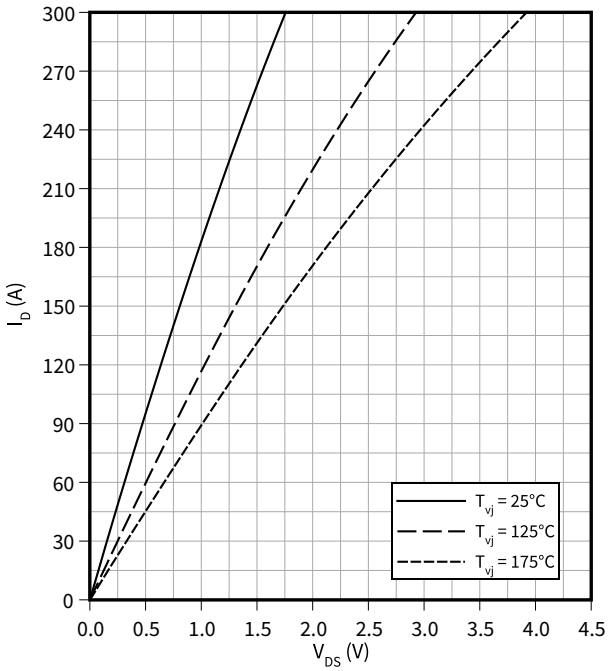
**Output characteristic (typical), MOSFET**
$I_D = f(V_{DS})$
$V_{GS}$ = 15 V



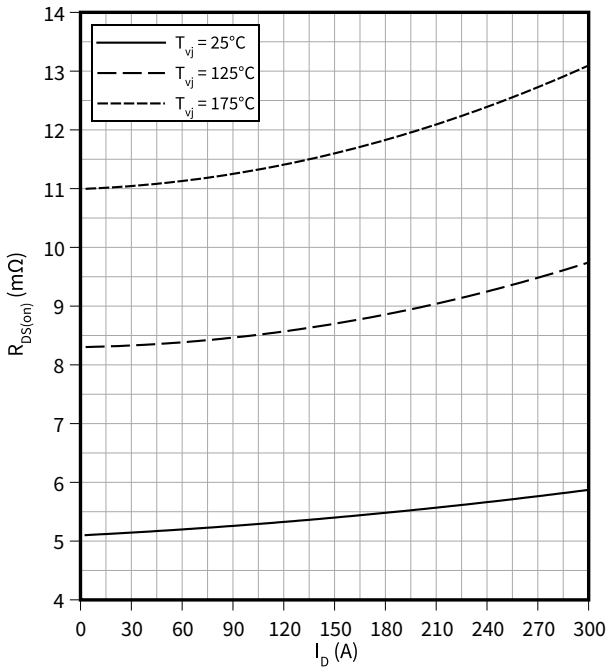

**Output characteristic (typical), MOSFET**
$I_D = f(V_{DS})$
$T_{vj}$ = 175 °C




**Output characteristic (typical), MOSFET**
$I_D = f(V_{DS})$
$V_{GS}$ = 18 V



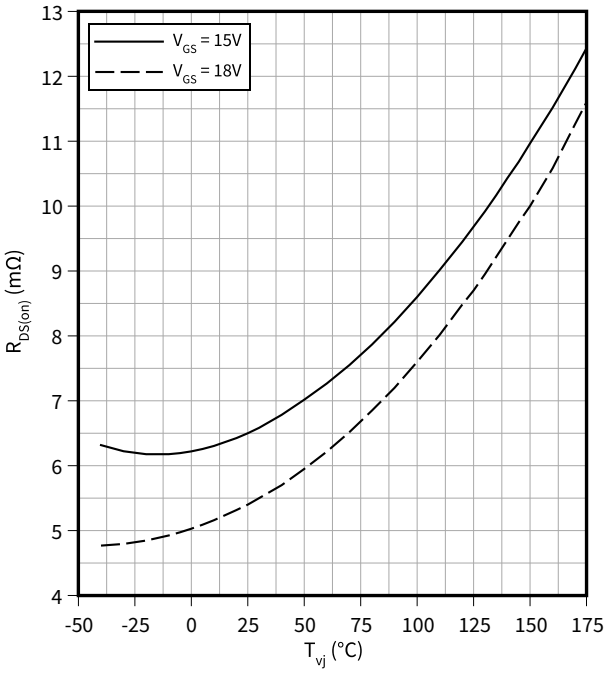

**Drain source on-resistance (typical), MOSFET**
$R_{DS(on)} = f(I_D)$
$V_{GS}$ =18 V



### Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(T_{vj})$

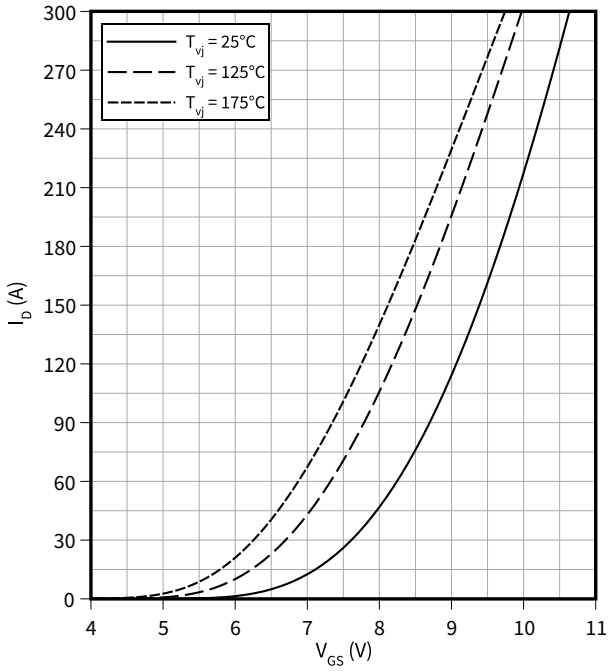
$I_D = 150$ A




### Transfer characteristic (typical), MOSFET

$I_D = f(V_{GS})$

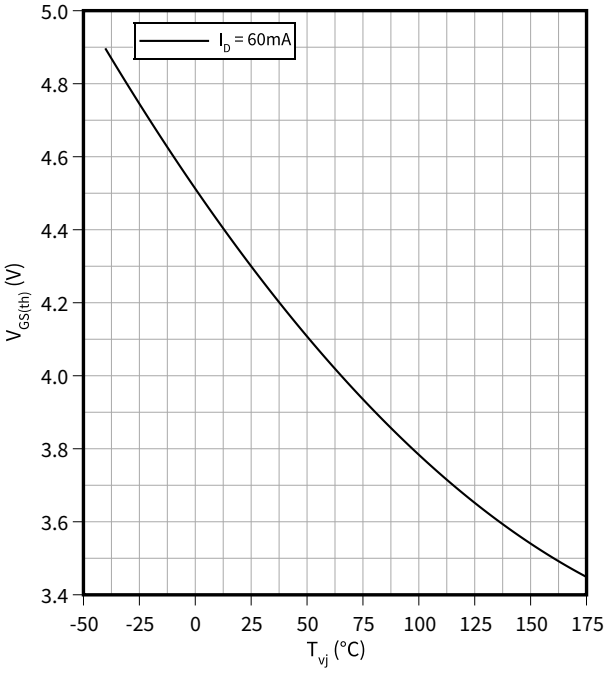
$V_{DS} = 20$ V




### Gate-source threshold voltage (typical), MOSFET

$V_{GS(th)} = f(T_{vj})$

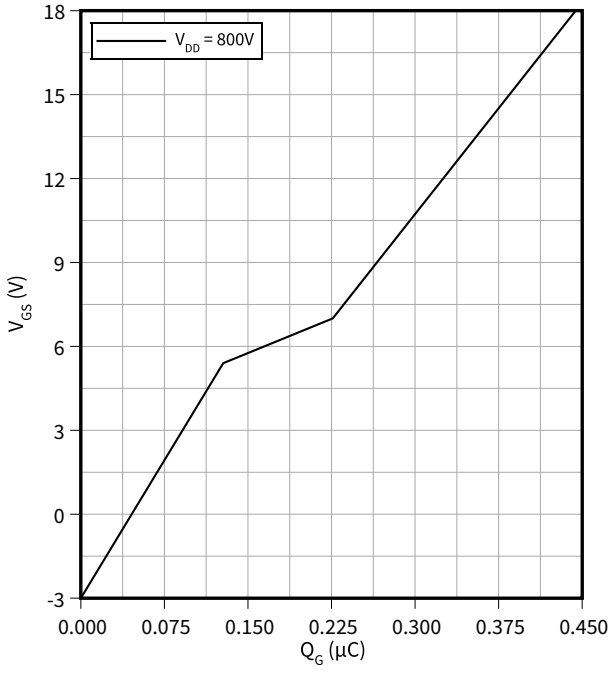
$V_{DS}=V_{GS}$




### Gate charge characteristic (typical), MOSFET

$V_{GS} = f(Q_G)$

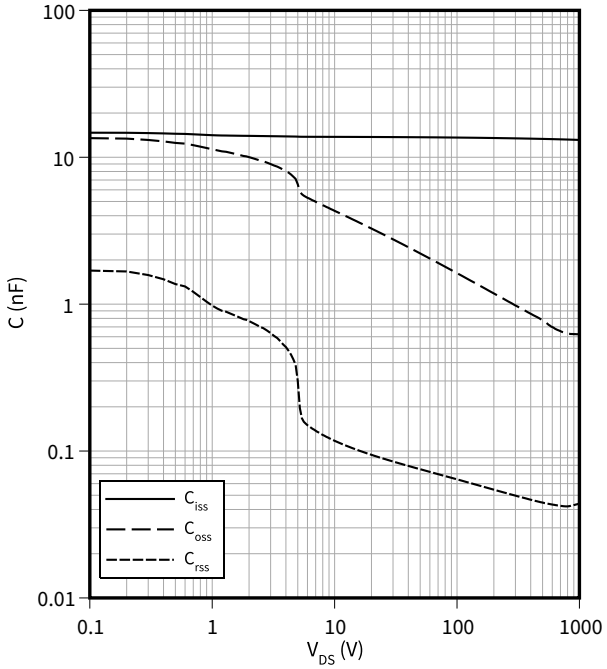
$I_D = 150$ A, $T_{vj} = 25$ °C



### Capacity characteristic (typical), MOSFET

$C = f(V_{DS})$

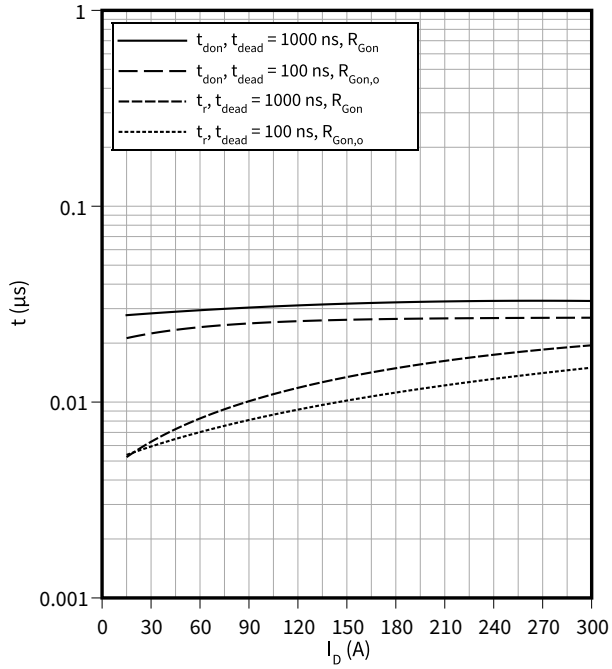
$f = 100\ kHz$, $T_{vj} = 25\ °C$, $V_{GS} = 0\ V$




### Switching times (typical), MOSFET

$t = f(I_D)$

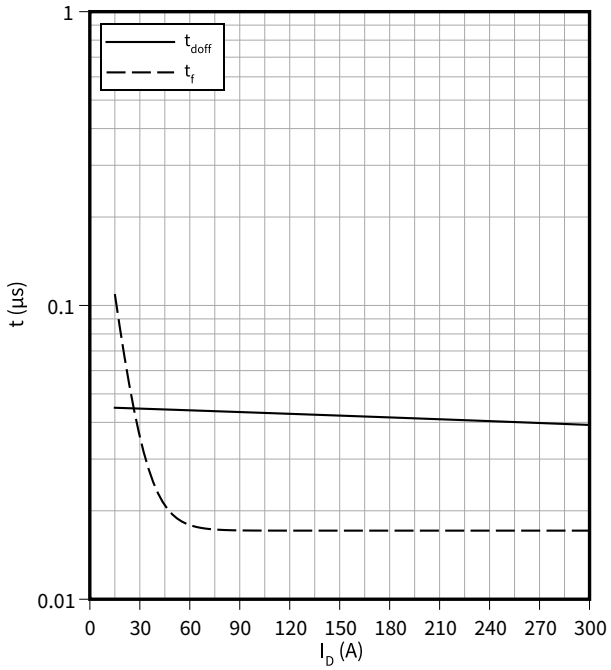
$V_{DD} = 600\ V$, $R_{Gon} = 2.7\ \Omega$, $R_{Gon,o} = 1.5\ \Omega$, $T_{vj} = 175\ °C$, $V_{GS} = -3/18\ V$




### Switching times (typical), MOSFET

$t = f(I_D)$

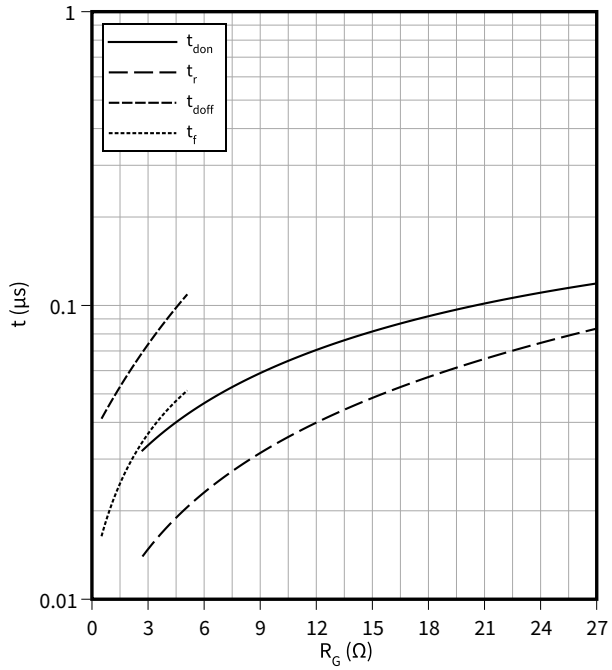
$R_{Goff} = 0.51\ \Omega$, $V_{DD} = 600\ V$, $T_{vj} = 175\ °C$, $V_{GS} = -3/18\ V$




### Switching times (typical), MOSFET

$t = f(R_G)$

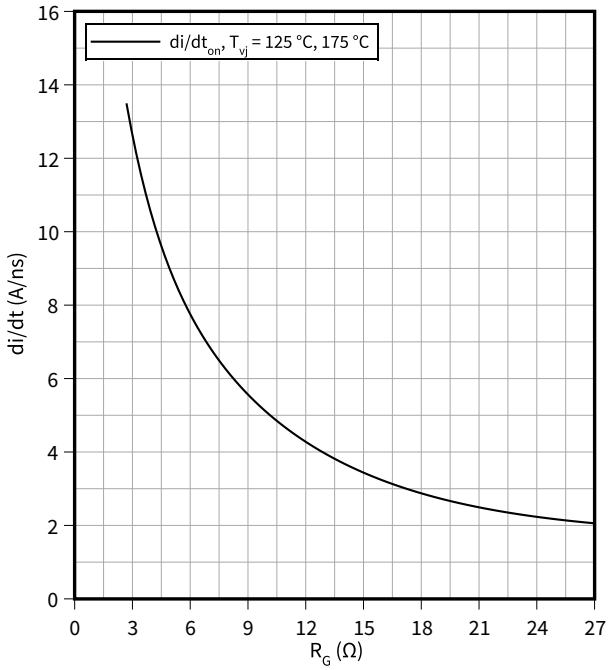
$V_{DD} = 600\ V$, $t_{dead} = 1000\ ns$, $I_D = 150\ A$, $T_{vj} = 175\ °C$, $V_{GS} = -3/18\ V$



### Current slope (typical), MOSFET

di/dt = f($R_G$)

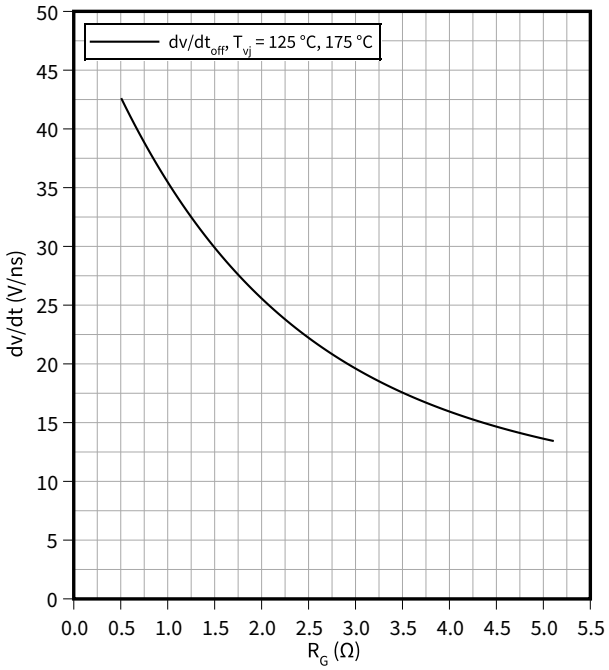
$V_{DD}$ = 600 V, $t_{dead}$ = 1000 ns, $I_D$ = 150 A, $V_{GS}$ = -3/18 V




### Voltage slope (typical), MOSFET

dv/dt = f($R_G$)

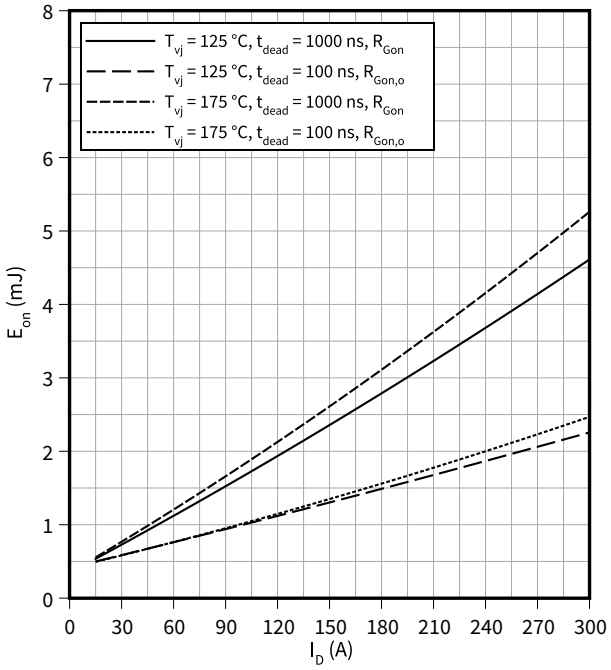
$V_{DD}$ = 600 V, $I_D$ = 150 A, $V_{GS}$ = -3/18 V




### Switching losses (typical), MOSFET

$E_{on}$ = f($I_D$)

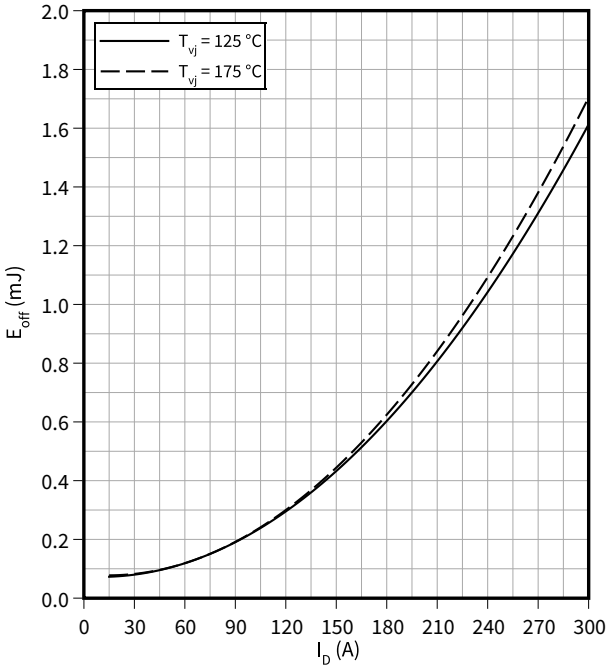
$R_{Gon}$ = 2.7 Ω, $V_{DD}$ = 600 V, $R_{Gon,o}$ = 1.5 Ω, $V_{GS}$ = -3/18 V




### Switching losses (typical), MOSFET

$E_{off}$ = f($I_D$)

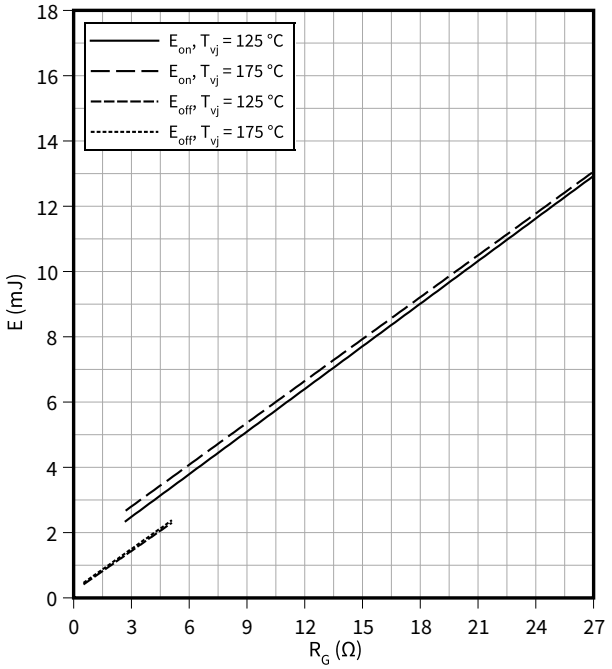
$R_{Goff}$ = 0.51 Ω, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V



### Switching losses (typical), MOSFET

$E = f(R_G)$

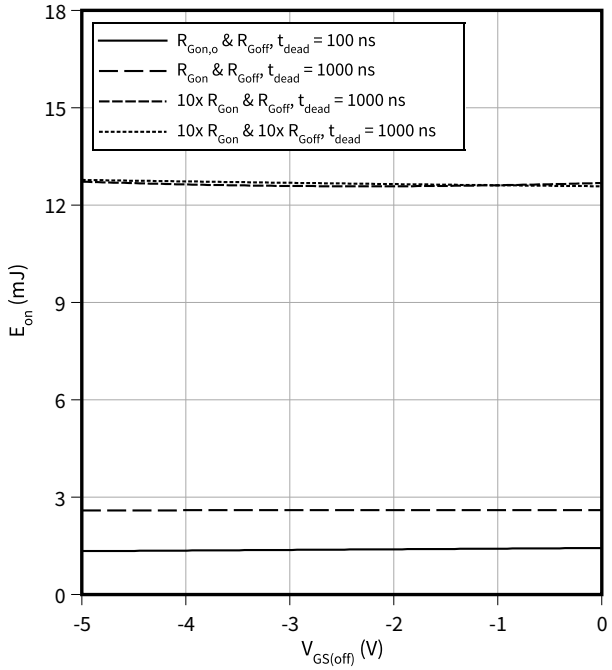
$V_{DD}$ = 600 V, $t_{dead}$ = 1000 ns, $I_D$ = 150 A, $V_{GS}$ = -3/18 V




### Switching losses (typical), MOSFET

$E_{on} = f(V_{GS(off)})$

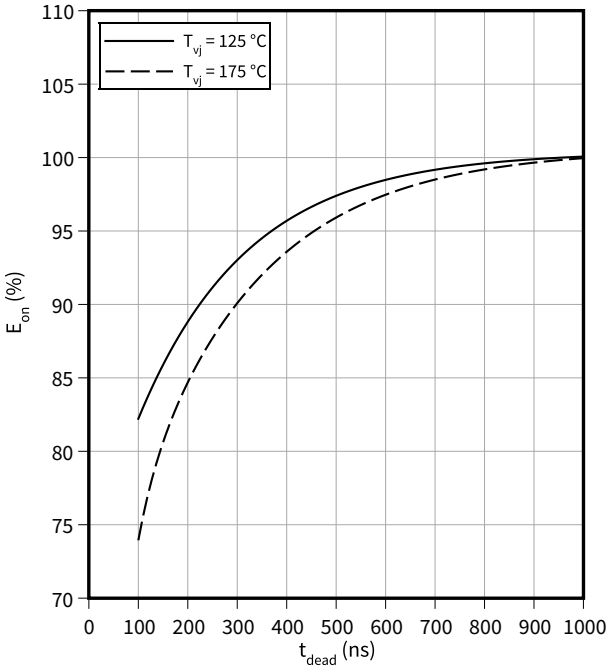
$R_{Goff}$ = 0.51 Ω, $V_{DD}$ = 600 V, $R_{Gon}$ = 2.7 Ω, $V_{GS(on)}$ = 18 V, $I_D$ = 150 A, $R_{Gon,o}$ = 1.5 Ω, $T_{vj}$ = 175 °C




### Switching losses (typical), MOSFET

$E_{on} = f(t_{dead})$

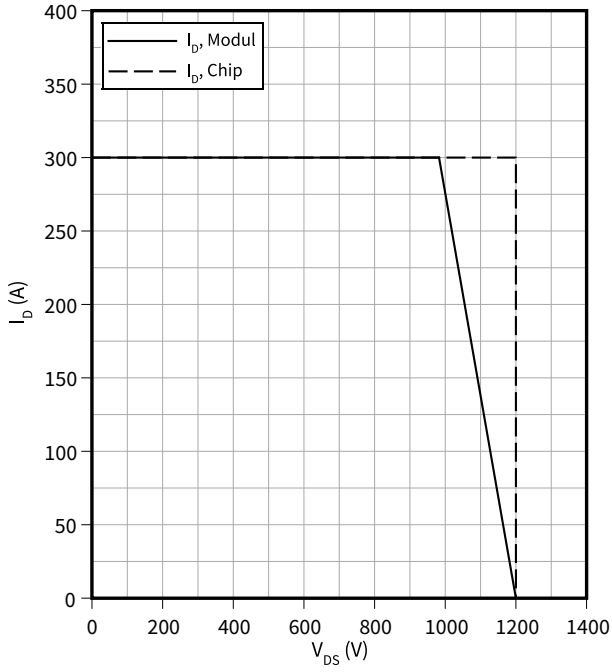
$R_{Gon}$ = 2.7 Ω, $I_D$ = 150 A, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V




### Reverse bias safe operating area (RBSOA), MOSFET

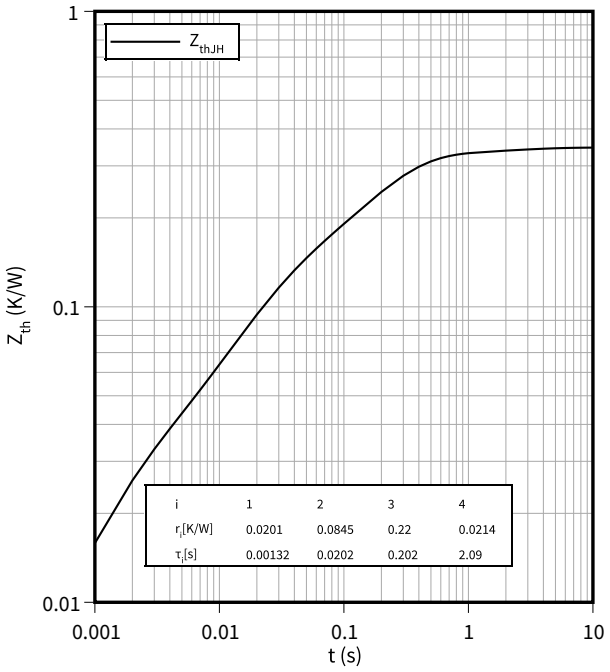
$I_D = f(V_{DS})$

$R_{Goff}$ = 0.51 Ω, $T_{vj}$ = 175 °C, $V_{GS}$ = -3/18 V



### Transient thermal impedance, MOSFET

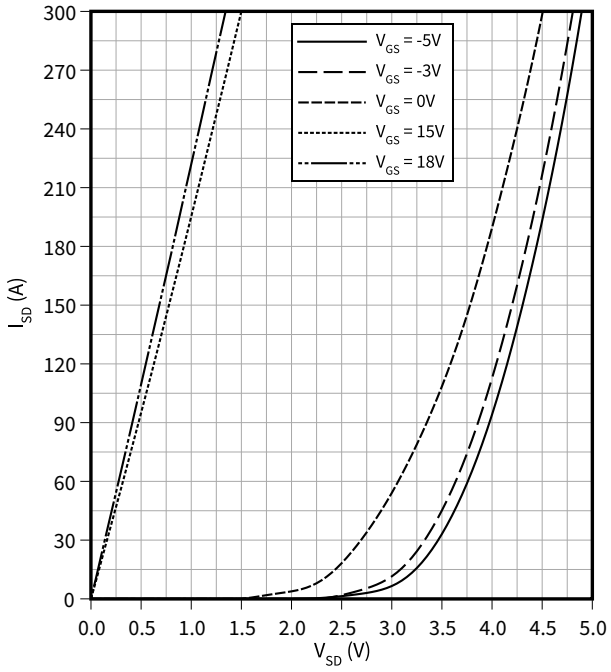
$Z_{th} = f(t)$




### Forward characteristic body diode (typical), MOSFET

$I_{SD} = f(V_{SD})$

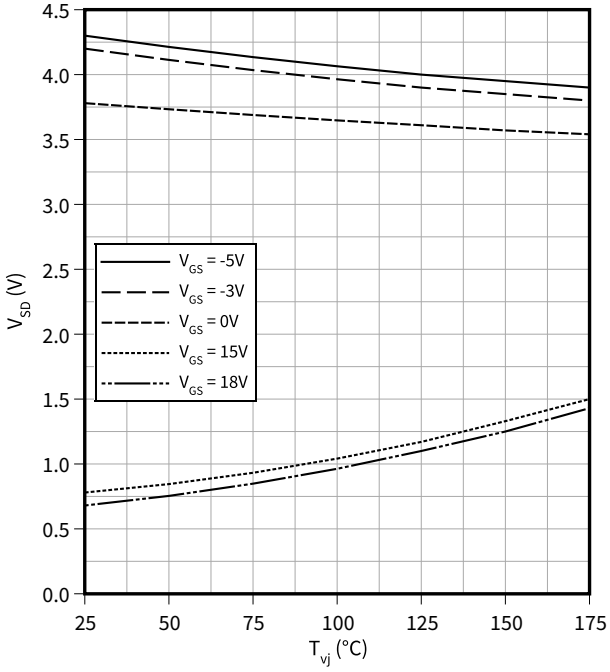
$T_{vj} = 25\ °C$




### Forward voltage of body diode (typical), MOSFET

$V_{SD} = f(T_{vj})$

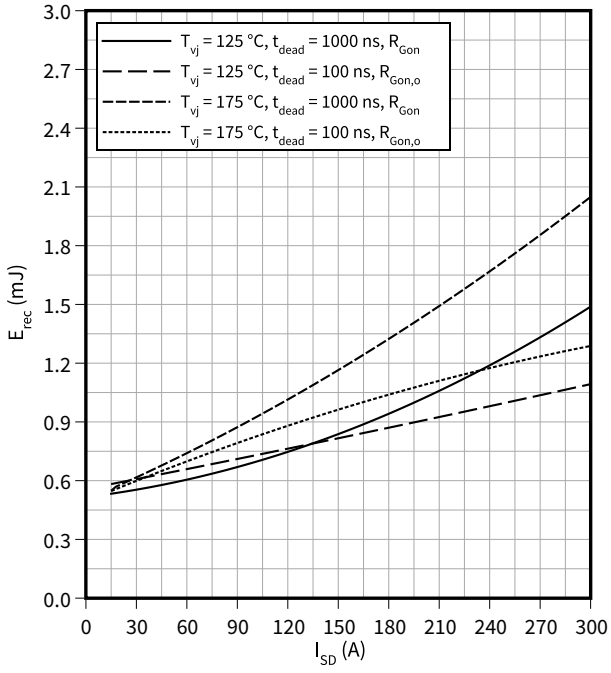
$I_{SD} = 150\ A$




### Switching losses body diode (typical), MOSFET

$E_{rec} = f(I_{SD})$

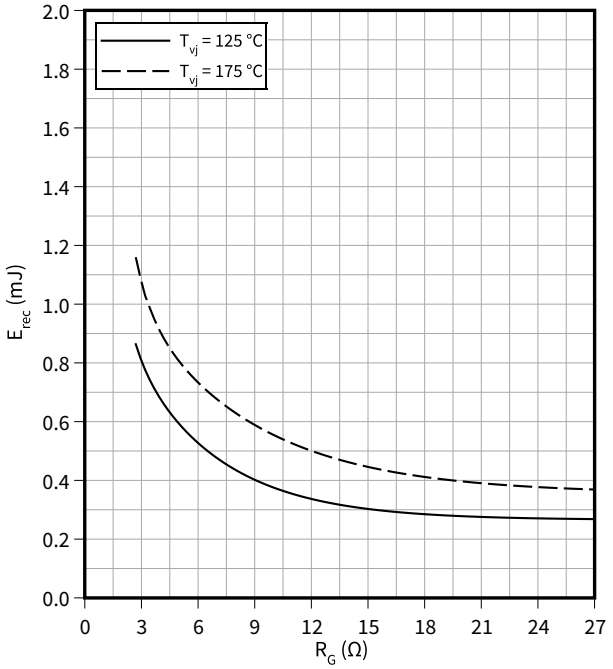
$R_{Gon} = 2.7\ \Omega$, $R_{Gon,o} = 1.5\ \Omega$, $V_{DD} = 600\ V$



### Switching losses body diode (typical), MOSFET

$E_{rec} = f(R_G)$

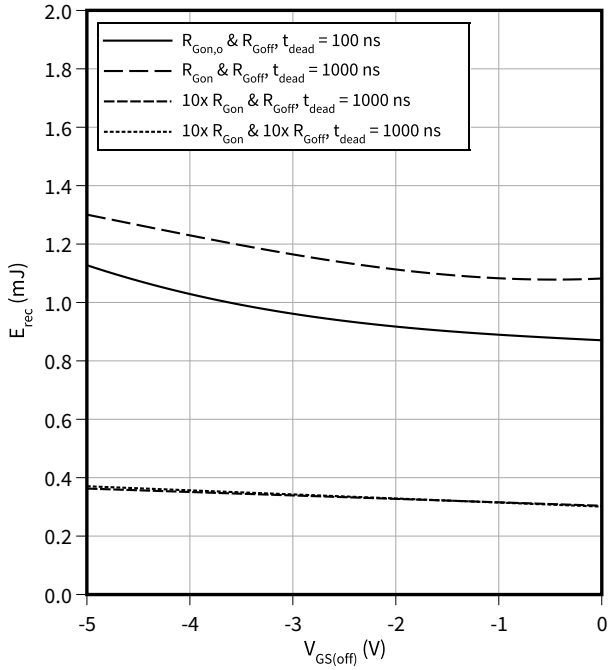
$t_{dead}$ = 1000 ns, $I_{SD}$ = 150 A, $V_{DD}$ = 600 V




### Switching losses body diode (typical), MOSFET

$E_{rec} = f(V_{GS(off)})$

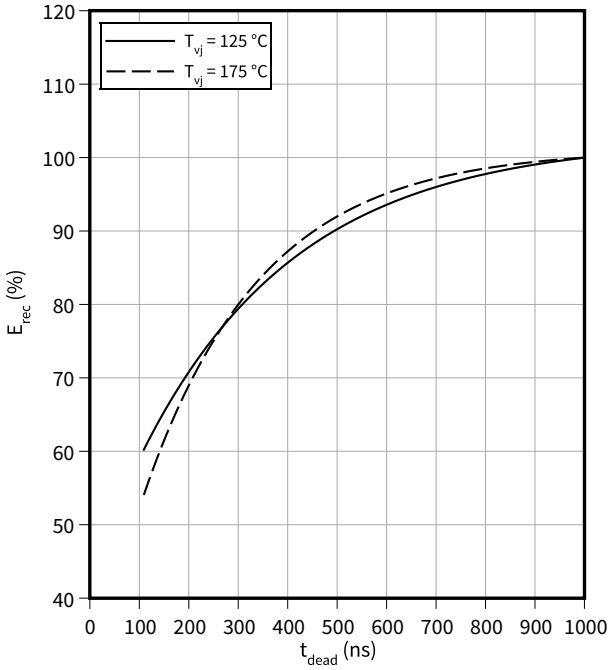
$R_{Goff}$ = 0.51 Ω, $R_{Gon}$ = 2.7 Ω, $V_{GS(on)}$ = 18 V, $I_{SD}$ = 150 A, $R_{Gon,o}$ = 1.5 Ω, $V_{DD}$ = 600 V, $T_{vj}$ = 175 °C




### Switching losses body diode (typical), MOSFET

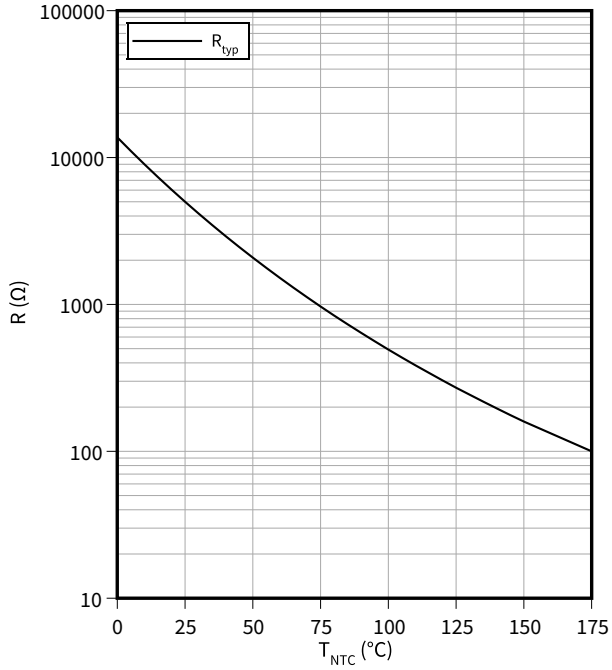
$E_{rec} = f(t_{dead})$

$R_{Gon}$ = 2.7 Ω, $I_D$ = 150 A, $V_{DD}$ = 600 V, $V_{GS}$ = -3/18 V




### Temperature characteristic (typical), NTC-Thermistor

$R = f(T_{NTC})$



# 6 Circuit diagram

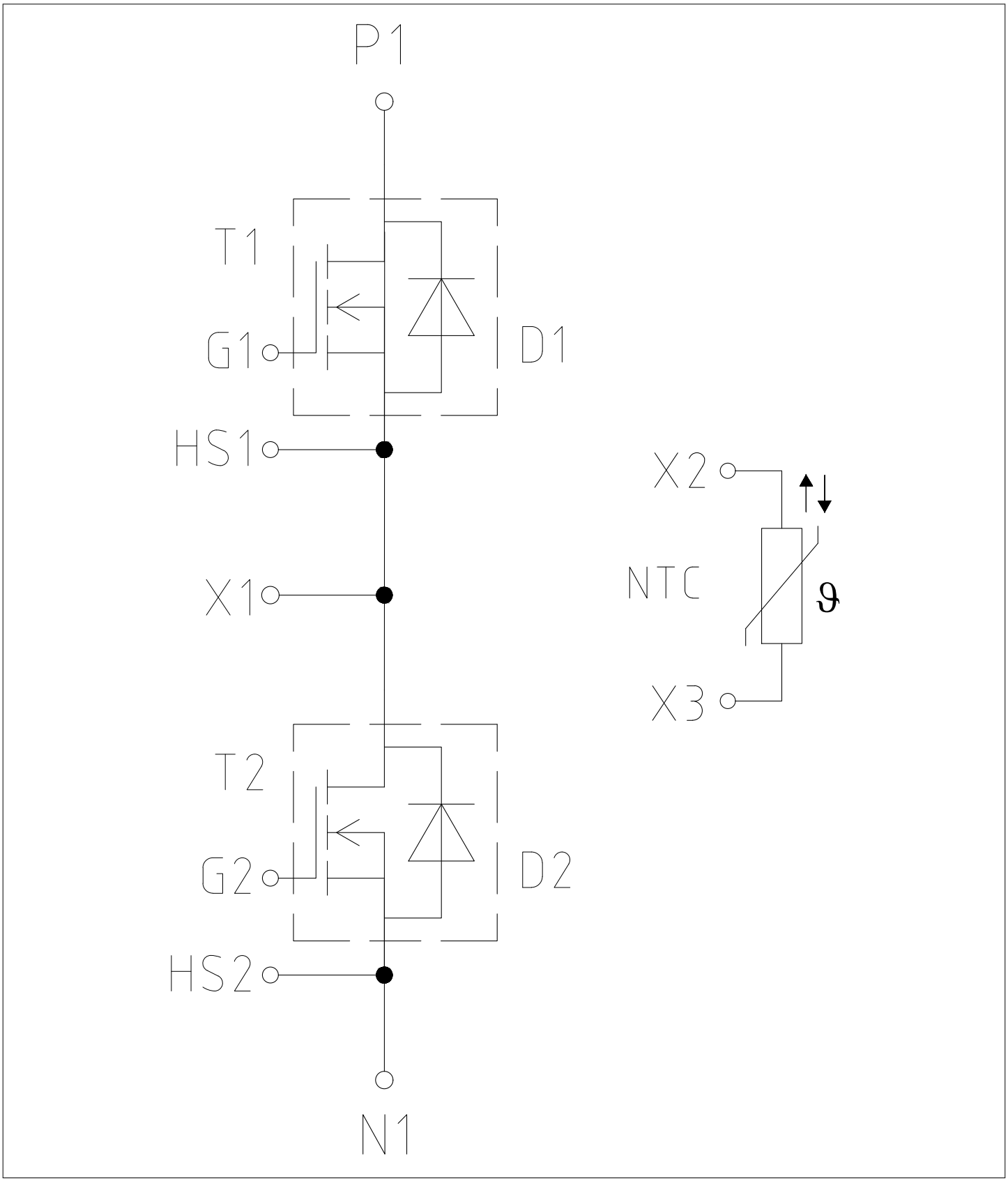



**Figure 1**

# 7 Package outlines

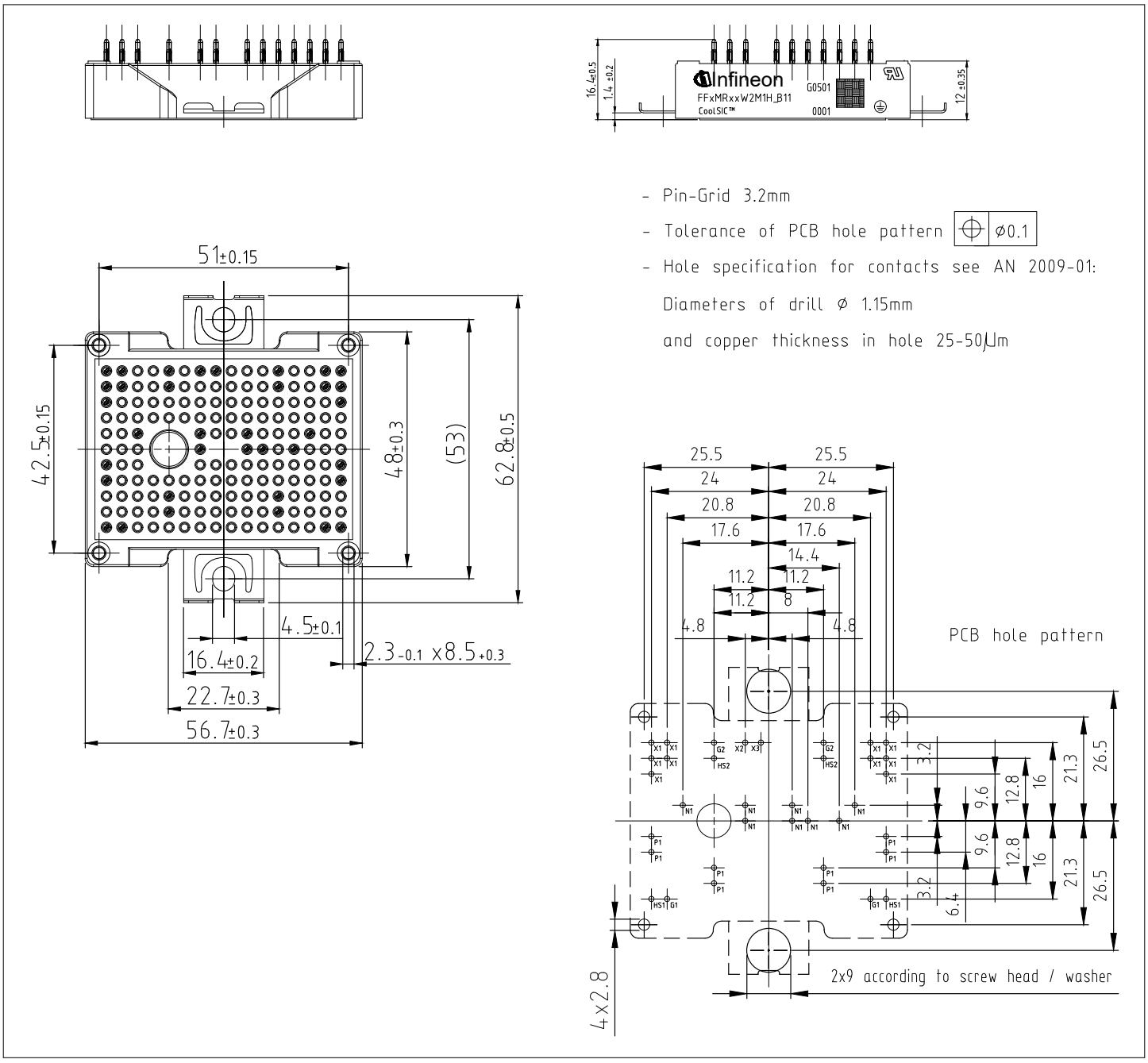



**Figure 2**

# 8 Module label code

| Module label code | | | |
|---|---|---|---|
| Code format | Data Matrix | | Barcode Code128 |
| Encoding | ASCII text | | Code Set A |
| Symbol size | 16x16 | | 23 digits |
| Standard | IEC24720 and IEC16022 | | IEC8859-1 |
| Code content | *Content*<br>Module serial number<br>Module material number<br>Production order number<br>Date code (production year)<br>Date code (production week) | *Digit*<br>1 – 5<br>6 - 11<br>12 - 19<br>20 – 21<br>22 – 23 | *Example*<br>71549<br>142846<br>55054991<br>15<br>30 |
| Example | 7154914284655054991530 | | 7154914284655054991530 |

**Figure 3**

# Revision history

| Document revision | Date of release | Description of changes |
|---|---|---|
| 0.10 | 2022-11-07 | Initial version |
| 0.20 | 2023-05-12 | Preliminary datasheet |
| 1.00 | 2025-02-28 | Final datasheet |
| 1.10 | 2025-03-14 | Final datasheet |

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**Edition 2025-03-14**

**Published by**

**Infineon Technologies AG**

**81726 Munich, Germany**



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**Document reference**
**IFX-ABF521-004**

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